

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/593,145	OKU ET AL.	
Examiner	Art Unit	
 IEEEREV & LUNDGREN	1630	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
VV	DATE	EXMR		
us patents and patent applications in east	10/23/2010	JSL		
inventors names in palm	10/23/2010	JSL		